S	earci	h Note:	S

Application/Control No.	Applicant(s)/Patent under Reexamination
10/781,474	BACKES ET AL.
Examiner	Art Unit .
TAN TRINH	2618

SEARCHED				
Class	Subclass	Date	Examine	
455	522	10/27/2006	π	
<del></del>	<i>434</i> 69			
	63.3			
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	452.1			
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	456.2			
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370	336			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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7/5	77/12		<u> </u>	
TEXT	Search)	1/28/6	7.7	
See p	VINTOUT)	7-9-1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	10/27/2006	π		
11	1/28/07	7.7.		
VO. NGUYEN	10/27/2006	Γ		
INTERFERENCE JEARCHI	1/28/07	7.7.		